## Far-infrared electrodynam ics of superconducting N b: com parison of theory and experim ent

A.E.Karakozov

L.F. Vereschagin Institute of High Pressure Physics, Russian Academ y of Sciences, 142190 Troitsk, Moscow region, Russia

E . G . M aksim ov  $\,^{\rm y}$ 

P.N. Lebedev Physical Institute, Russian Academy of Sciences, 119991 Moscow, Russia

A.V.Pronin  $^{\rm z}$ 

Institute of General Physics, Russian Academ y of Sciences, 119991 Moscow, Russia

C om plex conductivity spectra of superconducting N b are calculated from the rst principles in the frequency region around the energy gap and compared to the experimental results. The row experimental data obtained on thin Im s can be precisely described by these calculations.

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O bærvations of the superconducting energy gap in the far-infrared spectra of conventional superconductors have played an important role in establishing the Bardeen-Cooper-Schrie er (BCS) theory of superconductivity [1], and provided an evidence for importance of strong-coupling e ects predicted by E liashberg and H olstein theories [2].

D espite num erous studies [3, 4, 5, 6], for Nb the in uence of the strong coupling on optical properties is not as clear as it is for Pb or Hg, for instance. M ost recent reports on experim ental results of the surface in pedance in the m icrow ave region are rather contradictory. A nlage et al. [4] and K lein et al. [5] described their data basically by the BCS theory, while M arsiglio et al. [6] were not able to t their results either by the sim ple BCS m odel or by calculations according to the E liashberg theory citeeliash with the behavior of  ${}^{2}F$  (!) evaluated from tunnelling m easurem ents [8].

Only a few experimental studies [9, 10] determine both components of the complex conductivity, (!) =  $_1$ (!) + i  $_2$ (!), as a function of frequency in the most interesting frequency region – around the superconducting energy gap 2, that allows to make quantitative com – parison with theoretical strong-coupling calculations.

In one of such experiments [10], both, the real  $_1$  (!) and the imaginary  $_2$  (!) parts of the complex conductivity have been directly determined from the transmission and the phase shift spectra of high-quality thin niobium

In s on transparent substrates. The m easurem ents have

been perform ed at several tem peratures above and below  $T_c$  in the frequency range 5 to 30 cm  $^1$ , precisely the region where the superconducting gap lies. It has been shown that the overall frequency dependence of the conductivity can be described using the BCS form alism and assuming nite scattering elects. At the lowest tem peratures, how ever, some deviations from the BCS predictions have been observed in the frequency behavior of the complex conductivity. The deviations in the real part of

(!) could not be explained by the strong-coupling effects. In a subsequent comment [11], an attempt has been undertaken to explain the reported deviations by the granular structure of the sputtered Nb lm s. These

In s have been considered as a two-component system with an intrinsic BCS type conductivity  $_{BCS}$  and a grain-boundary conductivity  $_{bn}$  of Josephson type.

In this communication we show that the experimentally measured in Ref. [10] data for niobium, can be very accurately described using the st-principles approach developed in Ref. [12]. No Josephson junctions inside the sample are needed to be considered.

This rst-principles approach (for a review see [13]) allow sto calculate the electron and the phonon spectra of m etals and the spectral functions of the electron-phonon interaction. As a result, m any related to the electronphonon interaction properties, such as the tem peraturedependent electrical and therm al resistivity, the plasm a frequencies, the electron-phonon coupling constants, etc., have been com puted in R ef. [12].

For Nb, it has been shown that the electron-phonon contribution to the dc resistivity (T) is well described by the rst-principles calculated values of the plasma frequency  $!_{pl}=9.47$  eV and of the transport electron-phonon coupling constant  $_{tr}=1.17$  [14].

E lectronic address: karakozov@mtu-net.ru

<sup>&</sup>lt;sup>y</sup>E lectronic address: m aksim ov@ lpi.ru

<sup>&</sup>lt;sup>2</sup>P resent address: K am erlingh O nnes Laboratory, Leiden U niversity, 2300 RA Leiden, T he N etherlands

The resistivity (T) of niobium can be written as:

$$(T) = \frac{4}{!_{p1}^{2}} (T); \qquad (1)$$

where (T) is the relaxation rate:

$$(T) = \lim_{m \to P} + \int_{0}^{Z_{1}} d_{tr}^{2} ()F() = \frac{2}{\sinh^{2}(-2,T)}; (2)$$

The rst term here is the relaxation rate due to the temperature independent in purity scattering. The second term describes the tem perature dependent contribution from the electron-phonon interaction.

At considerably high tem peratures (T > 0.2  $_{\rm D}$  , here  $_{\rm D}$  is the D ebay tem perature) Eq. 2 can be simplied to:

$$(T) = \lim_{m \to \infty} + 2 \quad tr T;$$
 (3)

where  $t_r$  is the transport constant of the electronphonon coupling:

$$tr = 2 \int_{0}^{2} tr ()F() \frac{d}{tr}$$
 (4)

Fig. 1 shows temperature dependent part of the dc resistivity of the thin magnetron-sputtered Nb lm [15] in comparison with the literature data for bulk Nb [16]. The residual impurity resistivity of the lm is  $_0 = 4:1$  10<sup>6</sup> cm [10]. As it is seen from the gure, the experimental data obtained on a very thin (150 A) lm do not demonstrate signi cate di erence from the bulk results. The slope of the lm curve is som ewhat stepper than this for the bulk curve. A little decrease of a plasm a frequency (by no more than 10% of the bulk value) can describe this di erence.

The critical tem perature of the lm ,  $T_c = 8.31$  K [10], is also som ewhat below the bulk value (9.3 K), although for

In softhis thickness, it is rather high [17]. The in uence of the Im thickness on the properties of thin Im s in the norm al and superconducting states is certainly beyond the scope of this work. For detail discussions on this topic we refer to R ef. [18] and references therein. Here we just em phasize that the deviations of all the parameters for the Im measured in R ef. [10] from the bulk values are within 10%, thus the investigated Im can pretty accurately represent the bulk properties.

From the theoretical point of view, these small di erences between the lm and bulk properties can be understood, for instance, in terms of a simple approach developed by Testardi and M atteiss [19]. This approach introduces smearing of the rst-principles calculated band structure of m etals due to the lifetime e ects, which are certainly very essential in thin lm s, and allow s to calculate the density of states N (0) and the plasm a frequency as function of the phonon ( $_{ph}$ ) and the residual ( $_{0}$ ) resistivity. A lthough the Testardi-M atteiss approach is

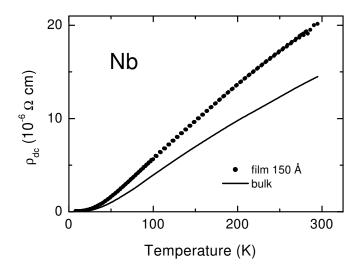


FIG.1: Tem perature dependence of phonon part of dc resistivity for thin-lm [10] and bulk [16] niobium.

oversimplied, it gives the right direction of the change in the lm properties compared to the bulk.

For calculation of the frequency dependent conductivity of N b, we have used the form ulas, obtained rstly by N am [20]. Here we present them in a shape convenient for num erical com putations:

$$(!) = \frac{!_{p1}^{2}}{4 \text{ i!}} \int_{0}^{Z_{1}!=2} d!^{0} [f(!^{0}) f(!^{0})!]$$

$$f \frac{1 + n(! !^{0})n(!^{0}) a(! !^{0}) a(! !^{0})}{"(! !^{0}) + "(!^{0}) + 2i_{imp}}$$

$$\frac{1 n(! !^{0})n(!^{0}) + a(! !^{0})a(!^{0})}{"(! !^{0}) + 2i_{imp}} g$$

$$+ d!^{0} [f(!^{0}) f(!^{0} + !)]$$

$$f \frac{1 n(! + !^{0})n(!^{0}) a(! + !^{0})a(!^{0})}{"(! + !^{0}) + "(!^{0}) + 2i_{imp}} g$$

$$\frac{1 + n(! + !^{0})n(!^{0}) + a(! + !^{0})a(!^{0})}{"(! + !^{0}) + "(!^{0}) + 2i_{imp}} g$$

$$\frac{1 + n(! + !^{0})n(!^{0}) + a(! + !^{0})a(!^{0})}{[(! + !^{0}) + "(!^{0}) + 2i_{imp}} g$$

$$Re \frac{1 n(! + !^{0})n(!^{0}) a(! + !^{0})a(!^{0})}{[(! + !^{0}) + "(!^{0}) + 2i_{imp}} g$$

$$Re \frac{1 n(! + !^{0})n(!^{0}) + a(! !^{0})a(!^{0})}{[(! + !^{0}) + "(!^{0}) + 2i_{imp}} g$$

$$(5)$$

where f is the Ferm i distribution and

"(!) = Z(!)<sup>p</sup> 
$$\frac{1}{2}$$
 (!);

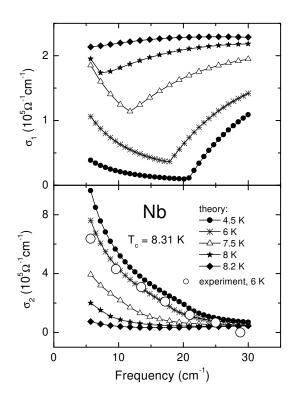


FIG. 2: Frequency dependence of the real (upper panel) and imaginary (bottom panel) parts of the complex conductivity of N b, as calculated from the rst principles. C om pare to F ig. 4 of R ef. [10]. As an example, we replot the experimental  $_2$  (!) data from this gure at T = 6 K.

$$n (!) = \frac{!}{!^{2} - 2(!)};$$

$$a (!) = \frac{!}{!^{2} - 2(!)};$$
(6)

The renorm alization function Z (!) and the energy gap (!) have been calculated from the E liashberg equation [7], which has a well-known form, and we do not reproduce it here. In our calculations, we used the E liashberg spectral function  ${}^{2}$ F (!) obtained from the rst-

berg spectral function  ${}^{2}F(!)$  obtained from the r principles calculations in Ref. [12].

In order to m atch to the experim entally m easured critical tem perature of the lm, we had to slightly increase the C oulom b pseudopotential in the E liashberg equation, in comparison with the bulk value. As lm s are usually m ore disordered than bulk sam ples, and as the disorder is known to increase the value of , this increasing seem s to be well grounded [21]. D ue to the reasons discussed above, while com puting the Eq. 5, the plasm a frequency has also been slightly changed from its bulk value of 9.47 eV to 9.2 eV.

The real and in aginary parts of the complex conductivity, as obtained from our calculations, are shown in Fig. 2 for several temperatures below  $T_c$ . At each tem – perature, the calculations have been made for 20 – 30 frequency points in the interval from 5 to 30 cm<sup>-1</sup>. As

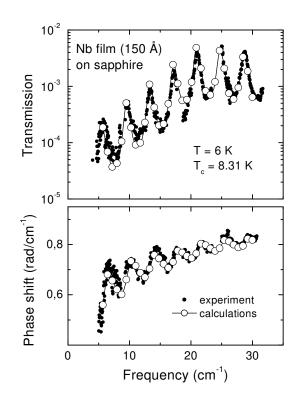


FIG.3: Examples of the transm ission and phase shift spectra of a 150-A thick N b lm on sapphire substrate. Open symbols - spectra, calculated from the rst principles. Solid symbols - experimental data from Ref. [10].

tem perature goes down, the energy gap clearly develops in the  $_1(!)$  spectra,  $_2(!)$  demonstrating a characteristic 1=!-divergency at !! 0.

To com pare our com putations with the raw experim ental data, we calculate the transmission and the phase shift spectra of a Nb lm on sapphire substrate (as has been m easured experimentally in Ref. [10]). For these calculations, the optical parameters of the substrate and the thicknesses of the lm and of the substrate have been taken from the same reference. The calculations were performed at all temperatures where the experimental data were available. An example of these calculations together with the experimental data are shown in Fig. 3 for  $T = 6 \text{ K} \cdot \text{C}$  learly, the computed spectra beautifully describe row experimental results.

In Fig. 2, as large open sym bols, we show  $_2$  data, calculated in Ref. [10] from the experimentally measured transmission and phase shift spectra for T = 6 K.Our

rst-principles calculations t these experim ental points very well, while the weak-coupling calculations have been shown to signi cantly deviate from the experim ental values, especially at the lowest frequencies (Fig. 5 of Ref. [10]). Thus, the e ect of strong coupling is clearly seen in the frequency-dependent conductivity in Nb.

W e should note, that at the lowest tem peratures and low frequencies, the real part of the com plex conductivity, calculated in Ref. [10] from the measured transmission and phase shift spectra, does not coincide with our

rst-principles calculations. We suggest this deviation is caused by the di culties in solving the inverse task – calculation of  $_1(!)$  and  $_2(!)$  from transmission and phase shift. At the lowest temperatures and at frequencies below the gap, the imaginary part of conductivity is much large than the real part. Consequently, the experimentally measured dynamic response (transmission and phase shift in our case) is mainly determined by  $_2(!)$ , while  $_1(!)$  has quite a minor in uence on experimental spectra. That causes large error bars in determination of  $_1(!)$  from experimental data.

Since the relaxation rate (which can be determined from Eqs. 1-2) is much larger than the gap value, or, in other words, the mean free path is smaller than the coherence length, the lm is in the dirty limit and the following expression for the penetration depth is valid:

where n is the norm al state conductivity:

$$n = \frac{!_{p1}^2}{4_{imp}}:$$
 (8)

For T = 4K, that gives = 880 A, in a good agreement with the experimental result, exp = 900 A [10].

To make better comparison with the experimental results of Ref. [10], we now compute the London penetration depth. By the London penetration depth we mean the penetration depth that would be observed in our superconductor, if it were in the clean limit. For this goal, we shall put  $_{im p} = 0$  in Eqs. 5, what gives:

$${}_{L}^{2} = \frac{!{}_{p1}^{2}}{2} \quad \operatorname{Re}_{0}^{2} \frac{!{}_{1}^{2}}{(!{}^{2} - {}_{2}^{2}(!))^{3=2}} \operatorname{ReZ}(!)$$
(9)

For T = 4 K we obtain  $_{\rm L}$  = 354 A, again in a perfect agreement with the experimental result,  $_{\rm L}^{\rm exp}$  = 350 A [10].

In conclusion, we have dem onstrated that the row experim entaldata on the frequency dependent conductivity of a thin Nb lm, obtained in Ref. [10], can be accurately described by the rst-principles calculations made for bulk Nb with just a sm all (10%) varying of such parameters as the plasm a frequency and the C oulom b pseudopotential. These deviations are most likely connected to the disordered nature of lm s, and can be understood in terms of the a simple theoretical approach [19]. No Josephson junctions inside the sample are needed to be considered to describe the experimental ndings. For the

rst time, in our know ledge, the rst-principles calculations of the complex conductivity of a superconductor, have been successfully compared with the experimentally W e are very gratefulto m any people for fruitfuldiscussions, especially to O.Dolgov. This work has been partially supported by RFBR (grants Nos. 01-02-16719 and 03-02-16252), by the Program of the Presidium of RAS "M acroscopicQ uantum M echanics", and by the Program of the Physical Science D ivision of RAS "Strongly correlated electrons". E.G.M. is grateful to Prof. J.J.M. B raat for the kind hospitality during the visit to the TU D elft, where a part of this work has been done.

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